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What is "Embedded - Microcontrollers"?

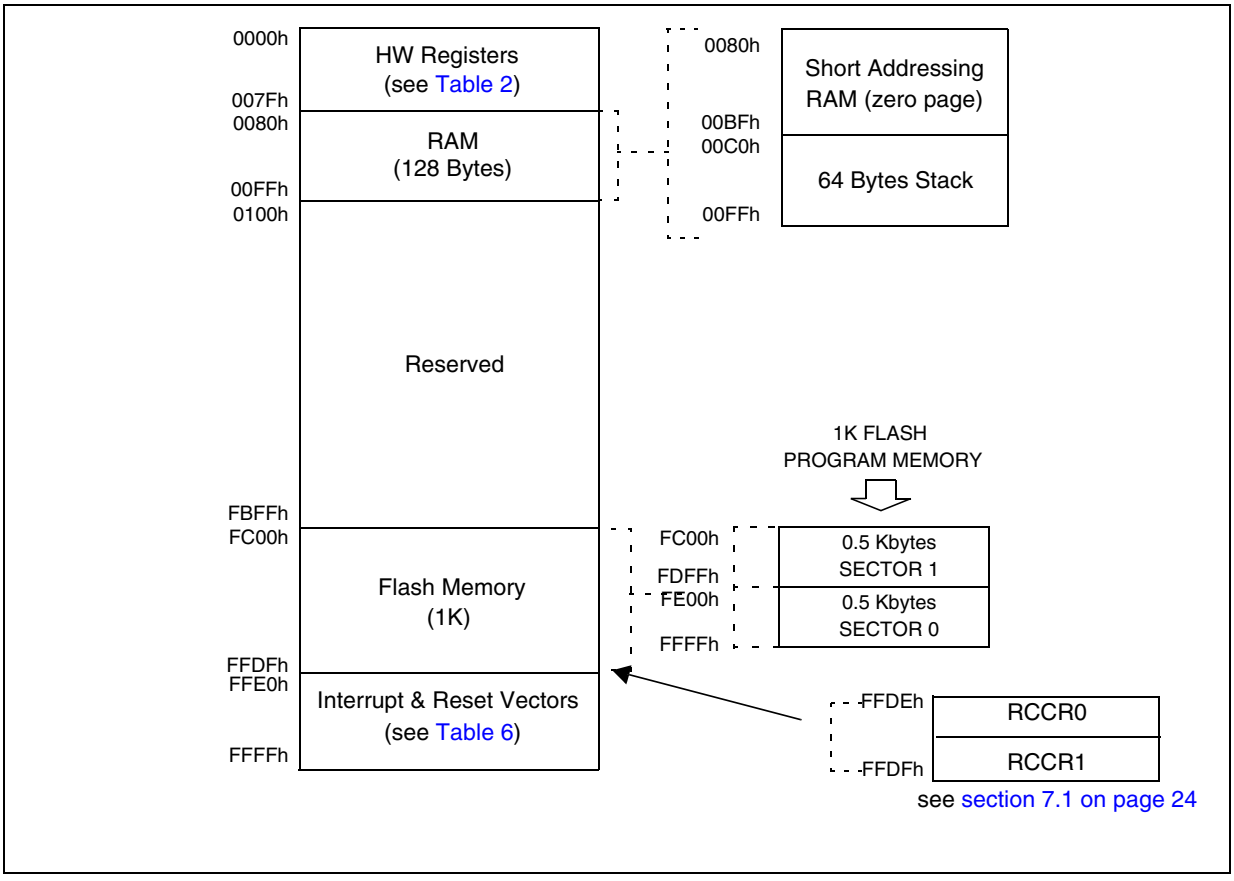
"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Obsolete
Core Processor	ST7
Core Size	8-Bit
Speed	8MHz
Connectivity	SPI
Peripherals	LVD, POR, PWM, WDT
Number of I/O	13
Program Memory Size	1KB (1K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	128 x 8
Voltage - Supply (Vcc/Vdd)	2.4V ~ 5.5V
Data Converters	-
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	16-SOIC (0.154", 3.90mm Width)
Supplier Device Package	16-SO
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/st7flites2y0m6

REGISTER AND MEMORY MAP (Cont'd)

Figure 5. Memory Map (ST7SUPERLITE)



FLASH PROGRAM MEMORY (Cont'd)

4.4 ICC interface

ICP needs a minimum of 4 and up to 6 pins to be connected to the programming tool. These pins are:

- $\overline{\text{RESET}}$: device reset
- V_{SS}: device power supply ground
- ICCCLK: ICC output serial clock pin
- ICCDATA: ICC input serial data pin
- CLKIN: main clock input for external source
- V_{DD}: application board power supply (optional, see Note 3)

Notes:

1. If the ICCCLK or ICCDATA pins are only used as outputs in the application, no signal isolation is necessary. As soon as the Programming Tool is plugged to the board, even if an ICC session is not in progress, the ICCCLK and ICCDATA pins are not available for the application. If they are used as inputs by the application, isolation such as a serial resistor has to be implemented in case another device forces the signal. Refer to the Programming Tool documentation for recommended resistor values.

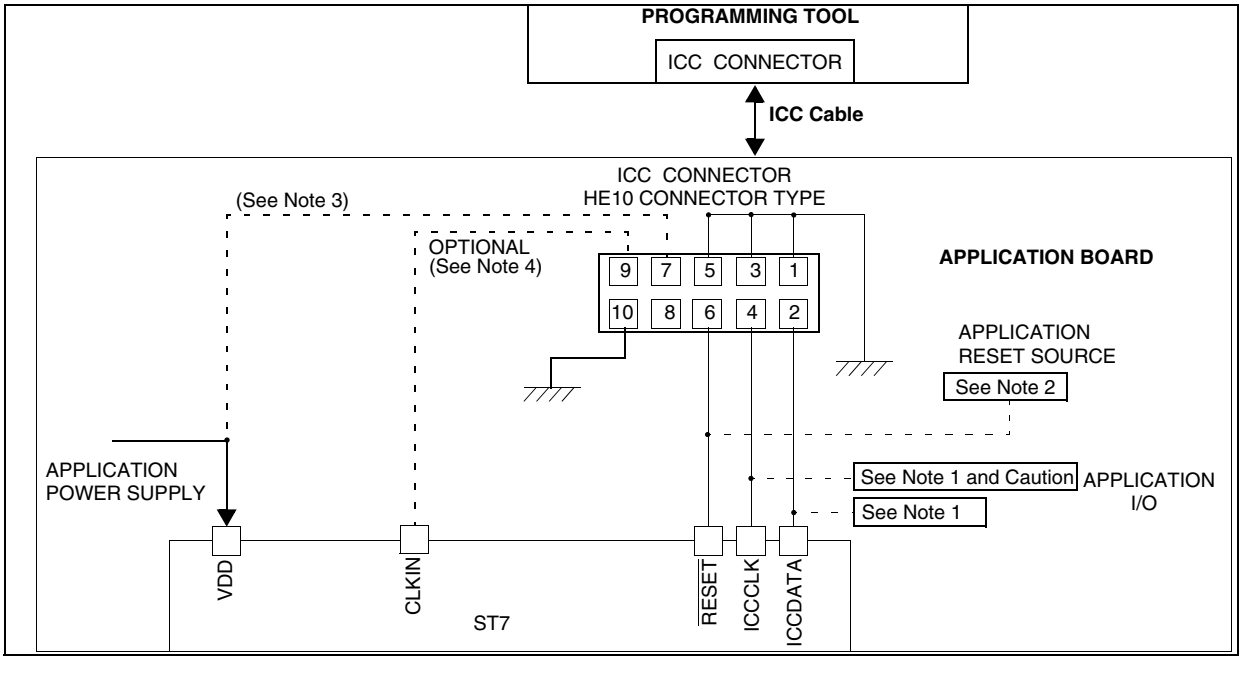
2. During the ICP session, the programming tool must control the $\overline{\text{RESET}}$ pin. This can lead to conflicts between the programming tool and the application reset circuit if it drives more than 5mA at high level (push pull output or pull-up resistor<1K). A schottky diode can be used to isolate the application $\overline{\text{RESET}}$ circuit in this case. When using a classical RC network with R>1K or a reset management IC with open drain output and pull-up resistor>1K, no additional components are needed. In all cases the user must ensure that no external reset is generated by the application during the ICC session.

3. The use of Pin 7 of the ICC connector depends on the Programming Tool architecture. This pin must be connected when using most ST Programming Tools (it is used to monitor the application power supply). Please refer to the Programming Tool manual.

4. Pin 9 has to be connected to the CLKIN pin of the ST7 when the clock is not available in the application or if the selected clock option is not programmed in the option byte.

Caution: During normal operation, ICCCLK pin must be pulled- up, internally or externally (external pull-up of 10K mandatory in noisy environment). This is to avoid entering ICC mode unexpectedly during a reset. In the application, even if the pin is configured as output, any reset will put it back in input pull-up.

Figure 6. Typical ICC Interface



FLASH PROGRAM MEMORY (Cont'd)

4.5 Memory Protection

There are two different types of memory protection: Read Out Protection and Write/Erase Protection which can be applied individually.

4.5.1 Read out Protection

Readout protection, when selected provides a protection against program memory content extraction and against write access to Flash memory. Even if no protection can be considered as totally unbreakable, the feature provides a very high level of protection for a general purpose microcontroller. Both program and data E^2 memory are protected.

In flash devices, this protection is removed by reprogramming the option. In this case, both program and data E^2 memory are automatically erased, and the device can be reprogrammed.

Read-out protection selection depends on the device type:

– In Flash devices it is enabled and removed through the FMP_R bit in the option byte.

– In ROM devices it is enabled by mask option specified in the Option List.

4.5.2 Flash Write/Erase Protection

Write/erase protection, when set, makes it impossible to both overwrite and erase program memory. It does not apply to E^2 data. Its purpose is to provide advanced security to applications and prevent any change being made to the memory content.

Warning: Once set, Write/erase protection can never be removed. A write-protected flash device is no longer reprogrammable.

Write/erase protection is enabled through the FMP_W bit in the option byte.

4.6 Related Documentation

For details on Flash programming and ICC protocol, refer to the ST7 Flash Programming Reference Manual and to the ST7 ICC Protocol Reference Manual.

4.7 Register Description

FLASH CONTROL/STATUS REGISTER (FCSR)
Read/Write
Reset Value: 000 0000 (00h)
1st RASS Key: 0101 0110 (56h)
2nd RASS Key: 1010 1110 (AEh)

7							0
0	0	0	0	0	OPT	LAT	PGM

Note: This register is reserved for programming using ICP, IAP or other programming methods. It controls the XFlash programming and erasing operations.

When an EPB or another programming tool is used (in socket or ICP mode), the RASS keys are sent automatically.

Table 3. FLASH Register Map and Reset Values

Address (Hex.)	Register Label	7	6	5	4	3	2	1	0
002Fh	**FCSR**						OPT	LAT	PGM
	Reset Value	0	0	0	0	0	0	0	0

DATA EEPROM (Cont'd)

5.4 POWER SAVING MODES

Wait mode

The DATA EEPROM can enter WAIT mode on execution of the WFI instruction of the microcontroller or when the microcontroller enters Active Halt mode.The DATA EEPROM will immediately enter this mode if there is no programming in progress, otherwise the DATA EEPROM will finish the cycle and then enter WAIT mode.

Active Halt mode

Refer to Wait mode.

Halt mode

The DATA EEPROM immediately enters HALT mode if the microcontroller executes the HALT instruction. Therefore the EEPROM will stop the function in progress, and data may be corrupted.

5.5 ACCESS ERROR HANDLING

If a read access occurs while E2LAT = 1, then the data bus will not be driven.

If a write access occurs while E2LAT = 0, then the data on the bus will not be latched.

If a programming cycle is interrupted (by RESET action), the integrity of the data in memory will not be guaranteed.

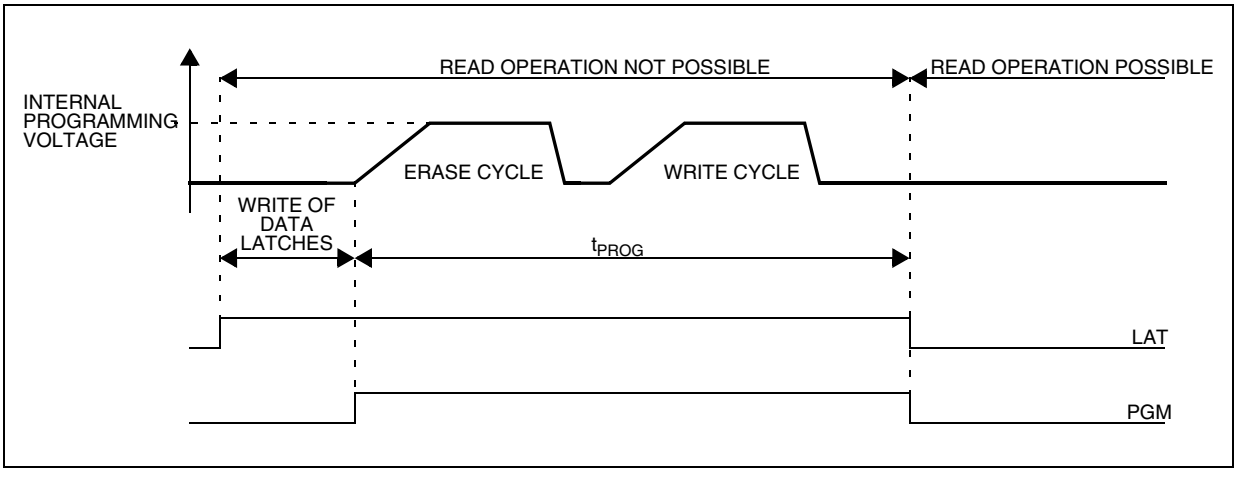
5.6 DATA EEPROM READ-OUT PROTECTION

The read-out protection is enabled through an option bit (see option byte section).

When this option is selected, the programs and data stored in the EEPROM memory are protected against read-out (including a re-write protection). In Flash devices, when this protection is removed by reprogramming the Option Byte, the entire Program memory and EEPROM is first automatically erased.

Note: Both Program Memory and data EEPROM are protected using the same option bit.

Figure 10. Data EEPROM Programming Cycle



INTERRUPTS (Cont'd)

Figure 18. Interrupt Processing Flowchart

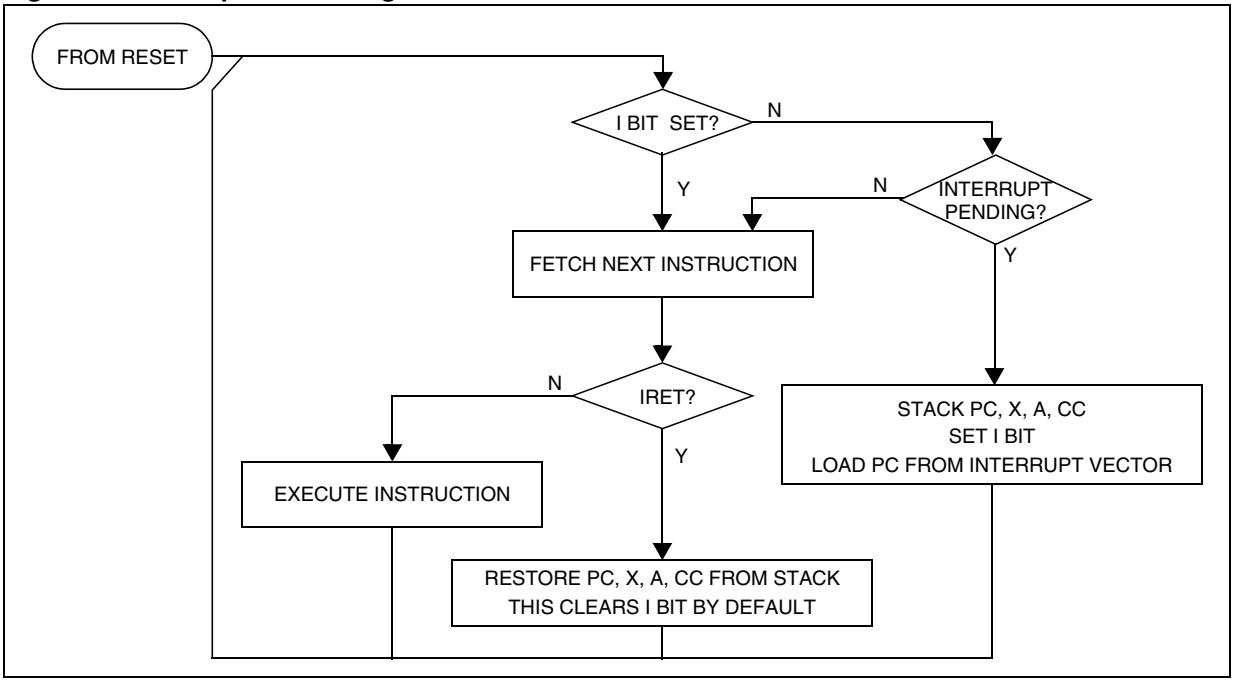


Table 6. Interrupt Mapping

N°	Source Block	Description	Register Label	Priority Order	Exit from HALT	Address Vector
	RESET	Reset	N/A	Highest Priority	yes	FFFEh-FFFFh
	TRAP	Software Interrupt			no	FFFCh-FFFDh
0		Not used				FFFAh-FFFBh
1	ei0	External Interrupt 0			yes	FFF8h-FFF9h
2	ei1	External Interrupt 1				FFF6h-FFF7h
3	ei2	External Interrupt 2				FFF4h-FFF5h
4	ei3	External Interrupt 3				FFF2h-FFF3h
5		Not used				FFF0h-FFF1h
6		Not used				FFEEh-FFEFh
7	SI	AVD interrupt	SICSR		no	FFECh-FFEDh
8	AT TIMER	AT TIMER Output Compare Interrupt	PWM0CSR		no	FFEAh-FFEBh
9		AT TIMER Overflow Interrupt	ATCSR		yes	FFE8h-FFE9h
10	LITE TIMER	LITE TIMER Input Capture Interrupt	LTCSR		no	FFE6h-FFE7h
11		LITE TIMER RTC Interrupt	LTCSR		yes	FFE4h-FFE5h
12	SPI	SPI Peripheral Interrupts	SPICSR	Lowest Priority	yes	FFE2h-FFE3h
13		Not used				FFE0h-FFE1h

INTERRUPTS (Cont'd)

EXTERNAL INTERRUPT CONTROL REGISTER (EICR)

Read/Write

Reset Value: 0000 0000 (00h)

7							0
IS31	IS30	IS21	IS20	IS11	IS10	IS01	IS00

Bit 7:6 = **IS3[1:0]** *ei3 sensitivity*
These bits define the interrupt sensitivity for ei3 (Port B0) according to Table 7.

Bit 5:4 = **IS2[1:0]** *ei2 sensitivity*
These bits define the interrupt sensitivity for ei2 (Port B3) according to Table 7.

Bit 3:2 = **IS1[1:0]** *ei1 sensitivity*
These bits define the interrupt sensitivity for ei1 (Port A7) according to Table 7.

Bit 1:0 = **IS0[1:0]** *ei0 sensitivity*
These bits define the interrupt sensitivity for ei0 (Port A0) according to Table 7.

Notes:

1. These 8 bits can be written only when the I bit in the CC register is set.

2. Changing the sensitivity of a particular external interrupt clears this pending interrupt. This can be used to clear unwanted pending interrupts. Refer to section "External interrupt function" on page 42.

Table 7. Interrupt Sensitivity Bits

ISx1	ISx0	External Interrupt Sensitivity
0	0	Falling edge & low level
0	1	Rising edge only
1	0	Falling edge only
1	1	Rising and falling edge

9 POWER SAVING MODES

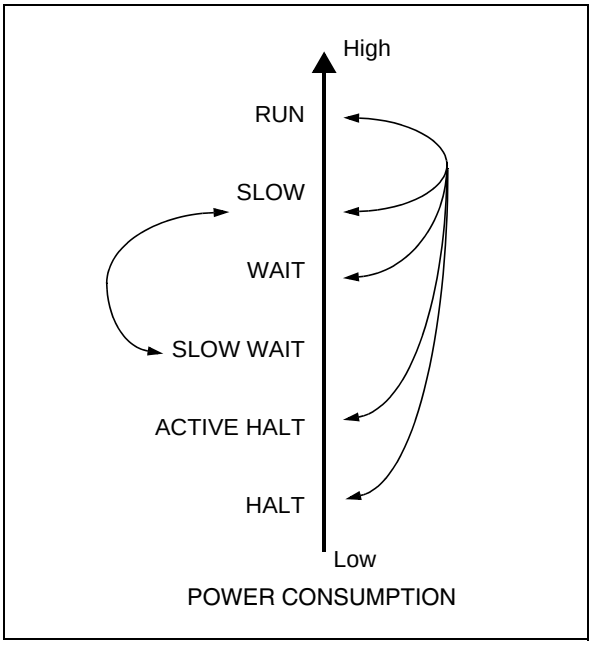
9.1 INTRODUCTION

To give a large measure of flexibility to the application in terms of power consumption, four main power saving modes are implemented in the ST7 (see Figure 22): SLOW, WAIT (SLOW WAIT), ACTIVE HALT and HALT.

After a RESET the normal operating mode is selected by default (RUN mode). This mode drives the device (CPU and embedded peripherals) by means of a master clock which is based on the main oscillator frequency (f_{OSC}).

From RUN mode, the different power saving modes may be selected by setting the relevant register bits or by calling the specific ST7 software instruction whose action depends on the oscillator status.

Figure 22. Power Saving Mode Transitions



9.2 SLOW MODE

This mode has two targets:

– To reduce power consumption by decreasing the internal clock in the device,

– To adapt the internal clock frequency (f_{CPU}) to the available supply voltage.

SLOW mode is controlled by the SMS bit in the MCCSR register which enables or disables Slow mode.

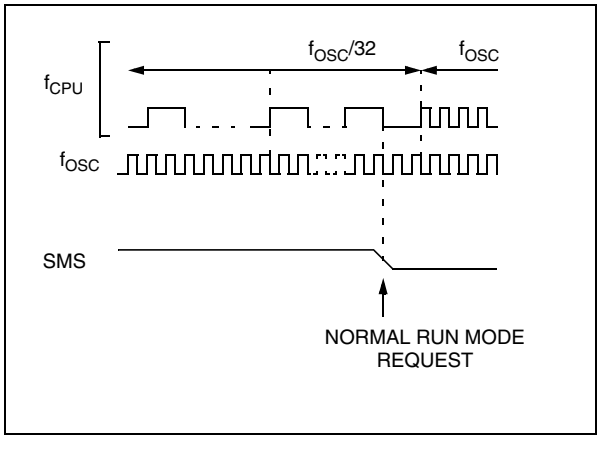
In this mode, the oscillator frequency is divided by 32. The CPU and peripherals are clocked at this lower frequency.

Notes:

SLOW-WAIT mode is activated when entering WAIT mode while the device is already in SLOW mode.

SLOW mode has no effect on the Lite Timer which is already clocked at $F_{OSC/32}$.

Figure 23. SLOW Mode Clock Transition



10 I/O PORTS

10.1 INTRODUCTION

The I/O ports offer different functional modes:
– transfer of data through digital inputs and outputs

and for specific pins:
– external interrupt generation
– alternate signal input/output for the on-chip peripherals.

An I/O port contains up to 8 pins. Each pin can be programmed independently as digital input (with or without interrupt generation) or digital output.

10.2 FUNCTIONAL DESCRIPTION

Each port has 2 main registers:

– Data Register (DR)

– Data Direction Register (DDR)

and one optional register:

– Option Register (OR)

Each I/O pin may be programmed using the corresponding register bits in the DDR and OR registers: bit X corresponding to pin X of the port. The same correspondence is used for the DR register.

The following description takes into account the OR register, (for specific ports which do not provide this register refer to the I/O Port Implementation section). The generic I/O block diagram is shown in Figure 29

10.2.1 Input Modes

The input configuration is selected by clearing the corresponding DDR register bit.

In this case, reading the DR register returns the digital value applied to the external I/O pin.

Different input modes can be selected by software through the OR register.

Note: Writing the DR register modifies the latch value but does not affect the pin status.

External interrupt function

When an I/O is configured as Input with Interrupt, an event on this I/O can generate an external interrupt request to the CPU.

Each pin can independently generate an interrupt request. The interrupt sensitivity is independently programmable using the sensitivity bits in the EICR register.

Each external interrupt vector is linked to a dedicated group of I/O port pins (see pinout description and interrupt section). If several input pins are selected simultaneously as interrupt source, these are logically ANDed. For this reason if one of the interrupt pins is tied low, it may mask the others.

External interrupts are hardware interrupts. Fetching the corresponding interrupt vector automatically clears the request latch. Changing the sensitivity of a particular external interrupt clears this pending interrupt. This can be used to clear unwanted pending interrupts.

Spurious interrupts

When enabling/disabling an external interrupt by setting/resetting the related OR register bit, a spurious interrupt is generated if the pin level is low and its edge sensitivity includes falling/rising edge. This is due to the edge detector input which is switched to '1' when the external interrupt is disabled by the OR register.

To avoid this unwanted interrupt, a "safe" edge sensitivity (rising edge for enabling and falling edge for disabling) has to be selected before changing the OR register bit and configuring the appropriate sensitivity again.

Caution: In case a pin level change occurs during these operations (asynchronous signal input), as interrupts are generated according to the current sensitivity, it is advised to disable all interrupts before and to reenable them after the complete previous sequence in order to avoid an external interrupt occurring on the unwanted edge.

This corresponds to the following steps:

1. To enable an external interrupt:
   – set the interrupt mask with the SIM instruction (in cases where a pin level change could occur)
   – select rising edge
   – enable the external interrupt through the OR register
   – select the desired sensitivity if different from rising edge
   – reset the interrupt mask with the RIM instruction (in cases where a pin level change could occur)
2. To disable an external interrupt:
   – set the interrupt mask with the SIM instruction SIM (in cases where a pin level change could occur)
   – select falling edge
   – disable the external interrupt through the OR register
   – select rising edge

11 ON-CHIP PERIPHERALS

11.1 LITE TIMER (LT)

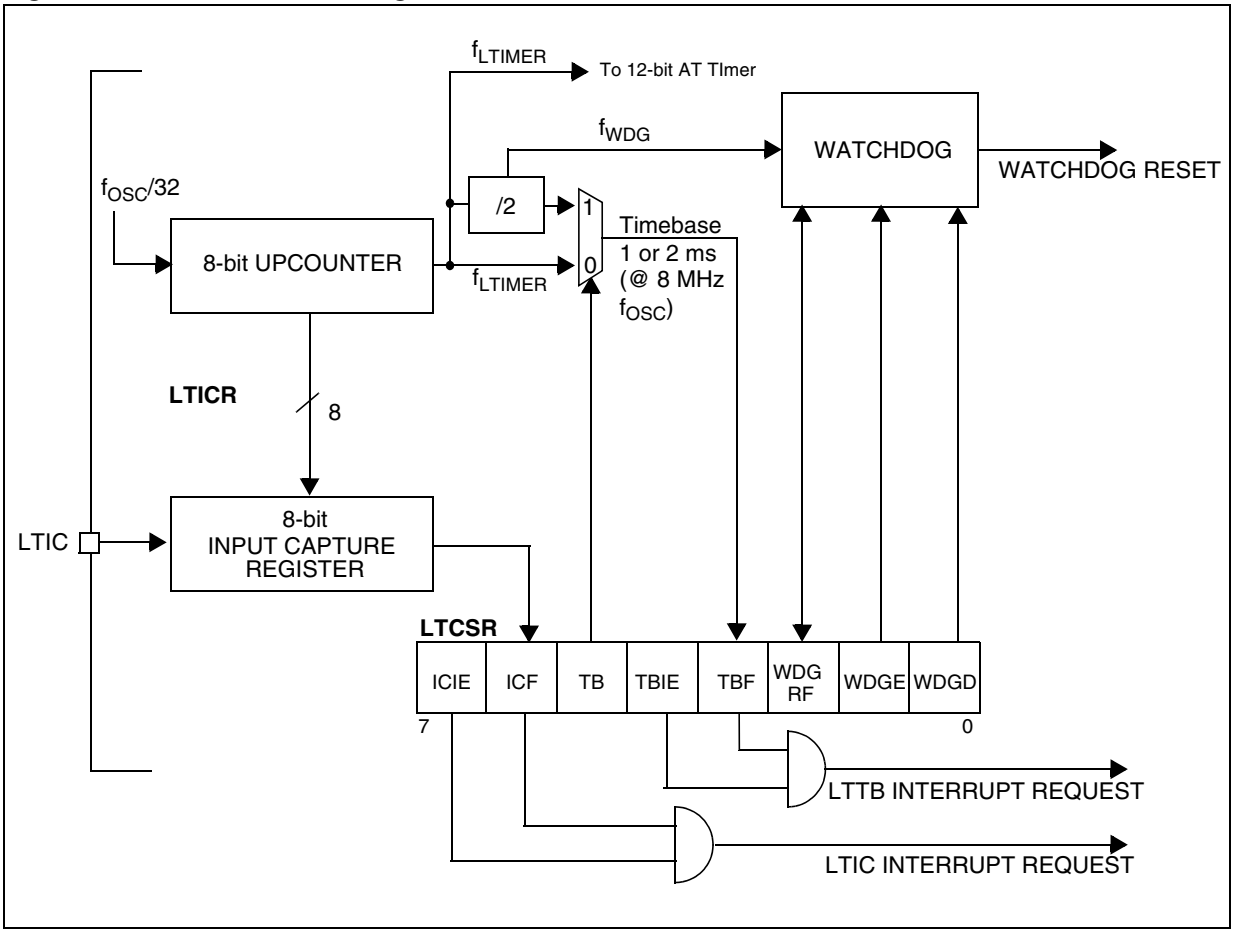
11.1.1 Introduction

The Lite Timer can be used for general-purpose timing functions. It is based on a free-running 8-bit upcounter with two software-selectable timebase periods, an 8-bit input capture register and watchdog function.

11.1.2 Main Features

- Realtime Clock
  - 8-bit upcounter
  - 1 ms or 2 ms timebase period (@ 8 MHz f_{OSC})
  - Maskable timebase interrupt
- Input Capture
  - 8-bit input capture register (LTICR)
  - Maskable interrupt with wakeup from Halt Mode capability
- Watchdog
  - Enabled by hardware or software (configurable by option byte)
  - Optional reset on HALT instruction (configurable by option byte)
  - Automatically resets the device unless disable bit is refreshed
  - Software reset (Forced Watchdog reset)
  - Watchdog reset status flag

Figure 31. Lite Timer Block Diagram



LITE TIMER (Cont'd)

11.1.6 Register Description

LITE TIMER CONTROL/STATUS REGISTER (LTCSR)
Read / Write
Reset Value: 0x00 0000 (x0h)

7							0
ICIE	ICF	TB	TBIE	TBF	WDGR	WDGE	WDGD

Bit 7 = **ICIE** *Interrupt Enable*
This bit is set and cleared by software.
0: Input Capture (IC) interrupt disabled
1: Input Capture (IC) interrupt enabled

Bit 6 = **ICF** *Input Capture Flag*
This bit is set by hardware and cleared by software by reading the LTICR register. Writing to this bit does not change the bit value.
0: No input capture
1: An input capture has occurred

Note: After an MCU reset, software must initialise the ICF bit by reading the LTICR register

Bit 5 = **TB** *Timebase period selection*
This bit is set and cleared by software.
0: Timebase period = t_{OSC} * 8000 (1ms @ 8 MHz)
1: Timebase period = t_{OSC} * 16000 (2ms @ 8 MHz)

Bit 4 = **TBIE** *Timebase Interrupt enable*
This bit is set and cleared by software.
0: Timebase (TB) interrupt disabled
1: Timebase (TB) interrupt enabled

Bit 3 = **TBF** *Timebase Interrupt Flag*
This bit is set by hardware and cleared by software reading the LTCSR register. Writing to this bit has no effect.
0: No counter overflow
1: A counter overflow has occurred

Bit 2 = **WDGRF** *Force Reset/ Reset Status Flag*
This bit is used in two ways: it is set by software to force a watchdog reset. It is set by hardware when a watchdog reset occurs and cleared by hardware or by software. It is cleared by hardware only when an LVD reset occurs. It can be cleared by software after a read access to the LTCSR register.
0: No watchdog reset occurred.
1: Force a watchdog reset (write), or, a watchdog reset occurred (read).

Bit 1 = **WDGE** *Watchdog Enable*
This bit is set and cleared by software.
0: Watchdog disabled
1: Watchdog enabled

Bit 0 = **WDGD** *Watchdog Reset Delay*
This bit is set by software. It is cleared by hardware at the end of each t_{WDG} period.
0: Watchdog reset not delayed
1: Watchdog reset delayed

LITE TIMER INPUT CAPTURE REGISTER (LTICR)
Read only
Reset Value: 0000 0000 (00h)

7							0
ICR7	ICR6	ICR5	ICR4	ICR3	ICR2	ICR1	ICR0

Bit 7:0 = **ICR[7:0]** *Input Capture Value*
These bits are read by software and cleared by hardware after a reset. If the ICF bit in the LTCSR is cleared, the value of the 8-bit up-counter will be captured when a rising or falling edge occurs on the LTIC pin.

Table 13. Lite Timer Register Map and Reset Values

Address (Hex.)	Register Label	7	6	5	4	3	2	1	0
0B	**LTCSR** Reset Value	ICIE 0	ICF x	TB 0	TBIE 0	TBF 0	WDGRF 0	WDGE 0	WDGD 0
0C	**LTICR** Reset Value	ICR7 0	ICR6 0	ICR5 0	ICR4 0	ICR3 0	ICR2 0	ICR1 0	ICR0 0

8-BIT A/D CONVERTER (ADC) (Cont'd)

11.4.3.3 Digital A/D Conversion Result

The conversion is monotonic, meaning that the result never decreases if the analog input does not and never increases if the analog input does not.

If the input voltage (V_{AIN}) is greater than or equal to V_{DDA} (high-level voltage reference) then the conversion result in the DR register is FFh (full scale) without overflow indication.

If input voltage (V_{AIN}) is lower than or equal to V_{SSA} (low-level voltage reference) then the conversion result in the DR register is 00h.

The A/D converter is linear and the digital result of the conversion is stored in the ADCDR register. The accuracy of the conversion is described in the parametric section.

R_{AIN} is the maximum recommended impedance for an analog input signal. If the impedance is too high, this will result in a loss of accuracy due to leakage and sampling not being completed in the alloted time.

11.4.3.4 A/D Conversion Phases

The A/D conversion is based on two conversion phases as shown in Figure 45:

- Sample capacitor loading [duration: t_{SAMPLE}]
  During this phase, the V_{AIN} input voltage to be measured is loaded into the C_{ADC} sample capacitor.
- A/D conversion [duration: t_{HOLD}]
  During this phase, the A/D conversion is computed (8 successive approximations cycles) and the C_{ADC} sample capacitor is disconnected from the analog input pin to get the optimum analog to digital conversion accuracy.
- The total conversion time:
  $t_{CONV} = t_{SAMPLE} + t_{HOLD}$

While the ADC is on, these two phases are continuously repeated.

At the end of each conversion, the sample capacitor is kept loaded with the previous measurement load. The advantage of this behaviour is that it minimizes the current consumption on the analog pin in case of single input channel measurement.

11.4.3.5 Software Procedure

Refer to the control/status register (CSR) and data register (DR) in Section 11.4.6 for the bit definitions and to Figure 45 for the timings.

ADC Configuration

The analog input ports must be configured as input, no pull-up, no interrupt. Refer to the «I/O ports» chapter. Using these pins as analog inputs does not affect the ability of the port to be read as a logic input.

In the CSR register:

– Select the CH[2:0] bits to assign the analog channel to be converted.

ADC Conversion

In the CSR register:

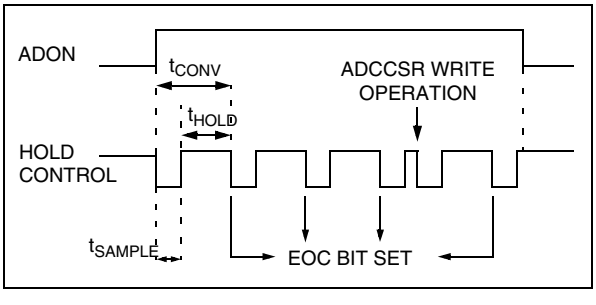
– Set the ADON bit to enable the A/D converter and to start the first conversion. From this time on, the ADC performs a continuous conversion of the selected channel.

When a conversion is complete

– The EOC bit is set by hardware.
– No interrupt is generated.
– The result is in the DR register and remains valid until the next conversion has ended.

A write to the ADCCSR register (with ADON set) aborts the current conversion, resets the EOC bit and starts a new conversion.

Figure 45. ADC Conversion Timings



11.4.4 Low Power Modes

Mode	Description
WAIT	No effect on A/D Converter
HALT	A/D Converter disabled. After wakeup from Halt mode, the A/D Converter requires a stabilization time before accurate conversions can be performed.

Note: The A/D converter may be disabled by resetting the ADON bit. This feature allows reduced power consumption when no conversion is needed and between single shot conversions.

11.4.5 Interrupts

None

ST7 ADDRESSING MODES (cont'd)

12.1.1 Inherent

All Inherent instructions consist of a single byte. The opcode fully specifies all the required information for the CPU to process the operation.

Inherent Instruction	Function
NOP	No operation
TRAP	S/W Interrupt
WFI	Wait For Interrupt (Low Power Mode)
HALT	Halt Oscillator (Lowest Power Mode)
RET	Subroutine Return
IRET	Interrupt Subroutine Return
SIM	Set Interrupt Mask
RIM	Reset Interrupt Mask
SCF	Set Carry Flag
RCF	Reset Carry Flag
RSP	Reset Stack Pointer
LD	Load
CLR	Clear
PUSH/POP	Push/Pop to/from the stack
INC/DEC	Increment/Decrement
TNZ	Test Negative or Zero
CPL, NEG	1 or 2 Complement
MUL	Byte Multiplication
SLL, SRL, SRA, RLC, RRC	Shift and Rotate Operations
SWAP	Swap Nibbles

12.1.2 Immediate

Immediate instructions have 2 bytes, the first byte contains the opcode, the second byte contains the operand value.

Immediate Instruction	Function
LD	Load
CP	Compare
BCP	Bit Compare
AND, OR, XOR	Logical Operations
ADC, ADD, SUB, SBC	Arithmetic Operations

12.1.3 Direct

In Direct instructions, the operands are referenced by their memory address.

The direct addressing mode consists of two submodes:

Direct (Short)

The address is a byte, thus requires only 1 byte after the opcode, but only allows 00 - FF addressing space.

Direct (Long)

The address is a word, thus allowing 64 Kbyte addressing space, but requires 2 bytes after the opcode.

12.1.4 Indexed (No Offset, Short, Long)

In this mode, the operand is referenced by its memory address, which is defined by the unsigned addition of an index register (X or Y) with an offset.

The indirect addressing mode consists of three submodes:

Indexed (No Offset)

There is no offset (no extra byte after the opcode), and allows 00 - FF addressing space.

Indexed (Short)

The offset is a byte, thus requires only 1 byte after the opcode and allows 00 - 1FE addressing space.

Indexed (Long)

The offset is a word, thus allowing 64 Kbyte addressing space and requires 2 bytes after the opcode.

12.1.5 Indirect (Short, Long)

The required data byte to do the operation is found by its memory address, located in memory (pointer).

The pointer address follows the opcode. The indirect addressing mode consists of two submodes:

Indirect (Short)

The pointer address is a byte, the pointer size is a byte, thus allowing 00 - FF addressing space, and requires 1 byte after the opcode.

Indirect (Long)

The pointer address is a byte, the pointer size is a word, thus allowing 64 Kbyte addressing space, and requires 1 byte after the opcode.

INSTRUCTION GROUPS (cont'd)

Mnemo	Description	Function/Example	Dst	Src	H	I	N	Z	C
JRULE	Jump if (C + Z = 1)	Unsigned <=							
LD	Load	dst <= src	reg, M	M, reg			N	Z	
MUL	Multiply	X,A = X * A	A, X, Y	X, Y, A	0				0
NEG	Negate (2's compl)	neg $10	reg, M				N	Z	C
NOP	No Operation								
OR	OR operation	A = A + M	A	M			N	Z	
POP	Pop from the Stack	pop reg	reg	M					
		pop CC	CC	M	H	I	N	Z	C
PUSH	Push onto the Stack	push Y	M	reg, CC					
RCF	Reset carry flag	C = 0							0
RET	Subroutine Return								
RIM	Enable Interrupts	I = 0				0			
RLC	Rotate left true C	C <= Dst <= C	reg, M				N	Z	C
RRC	Rotate right true C	C => Dst => C	reg, M				N	Z	C
RSP	Reset Stack Pointer	S = Max allowed							
SBC	Subtract with Carry	A = A - M - C	A	M			N	Z	C
SCF	Set carry flag	C = 1							1
SIM	Disable Interrupts	I = 1				1			
SLA	Shift left Arithmetic	C <= Dst <= 0	reg, M				N	Z	C
SLL	Shift left Logic	C <= Dst <= 0	reg, M				N	Z	C
SRL	Shift right Logic	0 => Dst => C	reg, M				0	Z	C
SRA	Shift right Arithmetic	Dst7 => Dst => C	reg, M				N	Z	C
SUB	Subtraction	A = A - M	A	M			N	Z	C
SWAP	SWAP nibbles	Dst[7..4] <=> Dst[3..0]	reg, M				N	Z	
TNZ	Test for Neg & Zero	tnz lbl1					N	Z	
TRAP	S/W trap	S/W interrupt				1			
WFI	Wait for Interrupt					0			
XOR	Exclusive OR	A = A XOR M	A	M			N	Z	

13.3.2 Operating Conditions with Low Voltage Detector (LVD)

T_A = -40 to 85°C, unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{IT+(LVD)}$	Reset release threshold (V_{DD} rise)	High Threshold Med. Threshold Low Threshold	4.00 [1] 3.40 [1] 2.65 [1]	4.25 3.60 2.90	4.50 3.80 3.15	V
$V_{IT-(LVD)}$	Reset generation threshold (V_{DD} fall)	High Threshold Med. Threshold Low Threshold	3.80 3.20 2.40	4.05 3.40 2.70	4.30 [1] 3.65 [1] 2.90 [1]	
V_{hys}	LVD voltage threshold hysteresis	$V_{IT+(LVD)}$-$V_{IT-(LVD)}$		200		mV
Vt_{POR}	V_{DD} rise time rate [2]		20		20000	µs/V
$t_{g(VDD)}$	Filtered glitch delay on V_{DD}	Not detected by the LVD			150	ns
$I_{DD(LVD)}$	LVD/AVD current consumption			220		µA

Notes:

1. Not tested in production.

2. Not tested in production. The V_{DD} rise time rate condition is needed to ensure a correct device power-on and LVD reset. When the V_{DD} slope is outside these values, the LVD may not ensure a proper reset of the MCU.

13.3.3 Auxiliary Voltage Detector (AVD) Thresholds

T_A = -40 to 85°C, unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{IT+(AVD)}$	1=>0 AVDF flag toggle threshold (V_{DD} rise)	High Threshold Med. Threshold Low Threshold	4.40 3.90 3.20	4.70 4.10 3.40	5.00 4.30 3.60	V
$V_{IT-(AVD)}$	0=>1 AVDF flag toggle threshold (V_{DD} fall)	High Threshold Med. Threshold Low Threshold	4.30 3.70 2.90	4.60 3.90 3.20	4.90 4.10 3.40	
V_{hys}	AVD voltage threshold hysteresis	$V_{IT+(AVD)}$-$V_{IT-(AVD)}$		150		mV
ΔV_{IT-}	Voltage drop between AVD flag set and LVD reset activation	V_{DD} fall		0.45		V

SUPPLY CURRENT CHARACTERISTICS (Cont'd)

Figure 58. Typical I_{DD} in WAIT vs. f_{CPU}

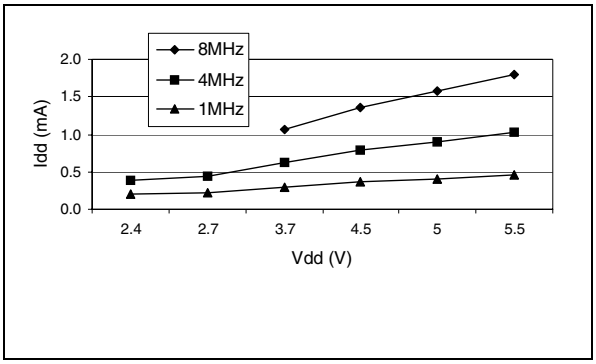


Figure 59. Typical I_{DD} in SLOW-WAIT vs. f_{CPU}

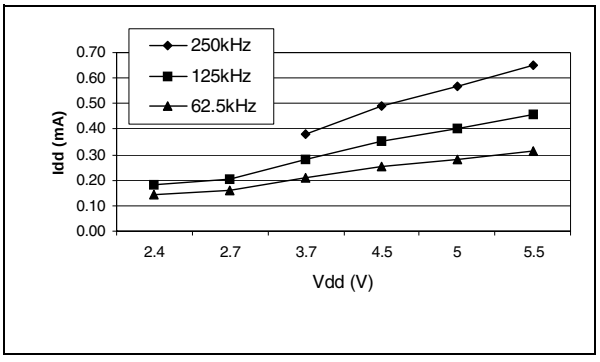
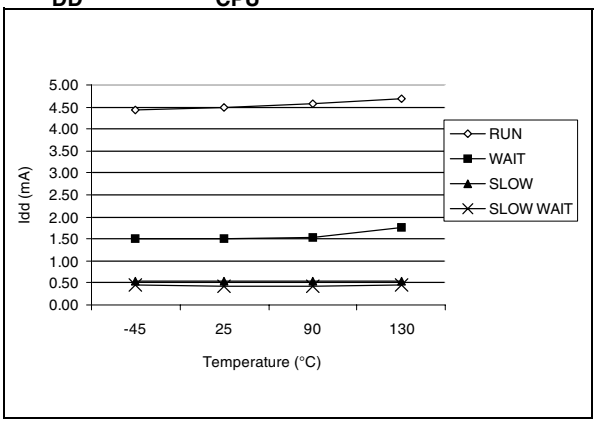


Figure 60. Typical I_{DD} vs. Temperature at V_{DD} = 5V and f_{CPU} = 8MHz



13.4.2 On-chip peripherals

Symbol	Parameter	Conditions		Typ	Unit
$I_{DD(AT)}$	12-bit Auto-Reload Timer supply current [1]	f_{CPU}=4MHz	V_{DD}=3.0V	150	µA
		f_{CPU}=8MHz	V_{DD}=5.0V	250	
$I_{DD(SPI)}$	SPI supply current [2]	f_{CPU}=4MHz	V_{DD}=3.0V	50	
		f_{CPU}=8MHz	V_{DD}=5.0V	300	
$I_{DD(ADC)}$	ADC supply current when converting [3]	f_{ADC}=4MHz	V_{DD}=3.0V	780	
			V_{DD}=5.0V	1100	

1. Data based on a differential I_{DD} measurement between reset configuration (timer stopped) and a timer running in PWM mode at f_{cpu}=8MHz.

2. Data based on a differential I_{DD} measurement between reset configuration and a permanent SPI master communication (data sent equal to 55h).

3. Data based on a differential I_{DD} measurement between reset configuration and continuous A/D conversions with amplifier off.

I/O PORT PIN CHARACTERISTICS (Cont'd)

13.8.2 Output Driving Current

Subject to general operating conditions for V_{DD}, f_{CPU}, and T_A unless otherwise specified.

Symbol	Parameter	Conditions			Min	Max	Unit
V_{OL} 1)	Output low level voltage for a standard I/O pin when 8 pins are sunk at same time (see Figure 65)	V_{DD}=5V	I_{IO}=+5mA	$T_A \le 85°C$ $T_A \ge 85°C$		1.0 1.2	V
			I_{IO}=+2mA	$T_A \le 85°C$ $T_A \ge 85°C$		0.4 0.5	
	Output low level voltage for a high sink I/O pin when 4 pins are sunk at same time (see Figure 66)		I_{IO}=+20mA,	$T_A \le 85°C$ $T_A \ge 85°C$		1.3 1.5	
			I_{IO}=+8mA	$T_A \le 85°C$ $T_A \ge 85°C$		0.75 0.85	
V_{OH} 2)	Output high level voltage for an I/O pin when 4 pins are sourced at same time (see Figure 72)		I_{IO}=-5mA,	$T_A \le 85°C$ $T_A \ge 85°C$	V_{DD}-1.5 V_{DD}-1.6		
			I_{IO}=-2mA	$T_A \le 85°C$ $T_A \ge 85°C$	V_{DD}-0.8 V_{DD}-1.0		
V_{OL} 1)3)	Output low level voltage for a standard I/O pin when 8 pins are sunk at same time (see Figure 64)	V_{DD}=3.3V	I_{IO}=+2mA	$T_A \le 85°C$ $T_A \ge 85°C$		0.5 0.6	
	Output low level voltage for a high sink I/O pin when 4 pins are sunk at same time		I_{IO}=+8mA	$T_A \le 85°C$ $T_A \ge 85°C$		0.5 0.6	
V_{OH} 2)3)	Output high level voltage for an I/O pin when 4 pins are sourced at same time		I_{IO}=-2mA	$T_A \le 85°C$ $T_A \ge 85°C$	V_{DD}-0.8 V_{DD}-1.0		
V_{OL} 1)3)	Output low level voltage for a standard I/O pin when 8 pins are sunk at same time	V_{DD}=2.7V	I_{IO}=+2mA	$T_A \le 85°C$ $T_A \ge 85°C$		0.6 0.7	
	Output low level voltage for a high sink I/O pin when 4 pins are sunk at same time		I_{IO}=+8mA	$T_A \le 85°C$ $T_A \ge 85°C$		0.6 0.7	
V_{OH} 2)3)	Output high level voltage for an I/O pin when 4 pins are sourced at same time (see Figure 69)		I_{IO}=-2mA	$T_A \le 85°C$ $T_A \ge 85°C$	V_{DD}-0.9 V_{DD}-1.0		

Notes:

1. The I_{IO} current sunk must always respect the absolute maximum rating specified in Section 13.2.2 and the sum of I_{IO} (I/O ports and control pins) must not exceed I_{VSS}.

2. The I_{IO} current sourced must always respect the absolute maximum rating specified in Section 13.2.2 and the sum of I_{IO} (I/O ports and control pins) must not exceed I_{VDD}.

3. Not tested in production, based on characterization results.

CONTROL PIN CHARACTERISTICS (Cont'd)

Figure 76. $\overline{\text{RESET}}$ pin protection when LVD is enabled.[1)2)3)4)]

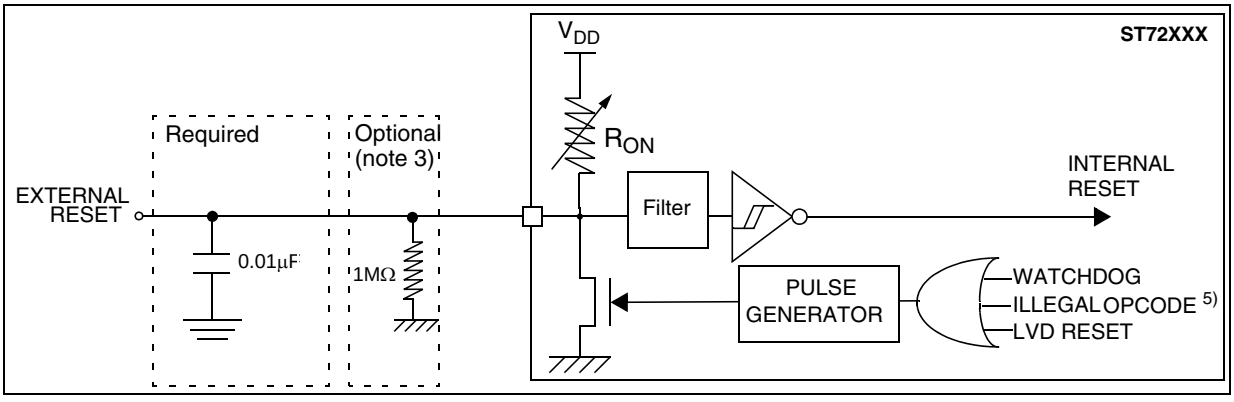
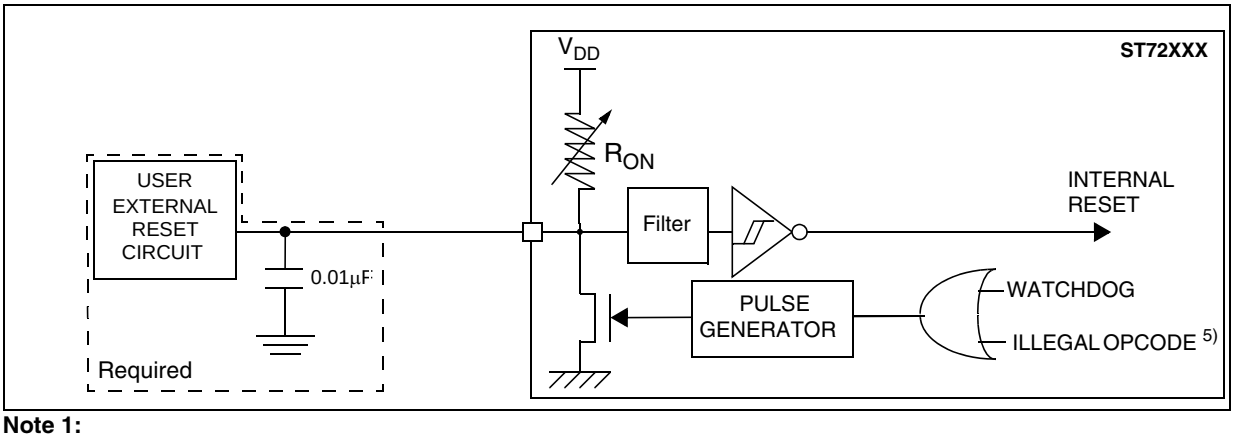


Figure 77. $\overline{\text{RESET}}$ pin protection when LVD is disabled.[1)]



Note 1:

- The reset network protects the device against parasitic resets.
- The output of the external reset circuit must have an open-drain output to drive the ST7 reset pad. Otherwise the device can be damaged when the ST7 generates an internal reset (LVD or watchdog).
- Whatever the reset source is (internal or external), the user must ensure that the level on the $\overline{\text{RESET}}$ pin can go below the V_{IL} max. level specified in section 13.9.1 on page 100. Otherwise the reset will not be taken into account internally.
- Because the reset circuit is designed to allow the internal RESET to be output in the $\overline{\text{RESET}}$ pin, the user must ensure that the current sunk on the $\overline{\text{RESET}}$ pin is less than the absolute maximum value specified for $I_{INJ(RESET)}$ in section 13.2.2 on page 82.

Note 2: When the LVD is enabled, it is recommended not to connect a pull-up resistor or capacitor. A 10nF pull-down capacitor is required to filter noise on the reset line.

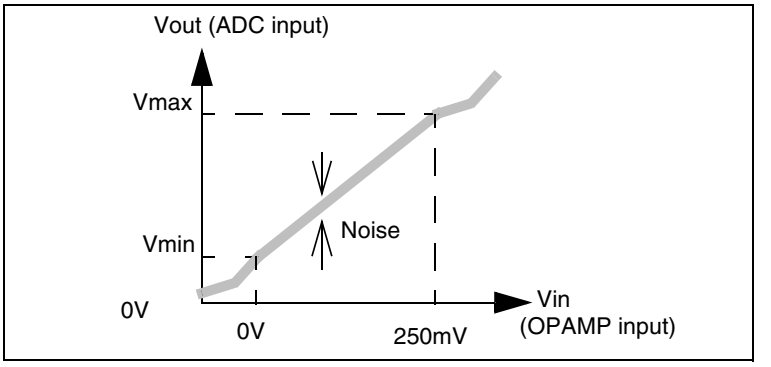
Note 3: In case a capacitive power supply is used, it is recommended to connect a 1MΩ pull-down resistor to the $\overline{\text{RESET}}$ pin to discharge any residual voltage induced by the capacitive effect of the power supply (this will add 5µA to the power consumption of the MCU).

Note 4: Tips when using the LVD:

- 1. Check that all recommendations related to ICCCLK and reset circuit have been applied (see caution in Table 1 on page 7 and notes above)
- 2. Check that the power supply is properly decoupled (100nF + 10µF close to the MCU). Refer to AN1709 and AN2017. If this cannot be done, it is recommended to put a 100nF + 1MΩ pull-down on the $\overline{\text{RESET}}$ pin.
- 3. The capacitors connected on the RESET pin and also the power supply are key to avoid any start-up marginality. In most cases, steps 1 and 2 above are sufficient for a robust solution. Otherwise: replace 10nF pull-down on the $\overline{\text{RESET}}$ pin with a 5µF to 20µF capacitor."

Note 5: See "Illegal Opcode Reset" on page 78. for more details on illegal opcode reset conditions

ADC CHARACTERISTICS (Cont'd)



Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{DD(AMP)}$	Amplifier operating voltage		4.5		5.5	V
V_{IN}	Amplifier input voltage	V_{DD}=5V	0		250	mV
V_{OFFSET}	Amplifier offset voltage			200		mV
V_{STEP}	Step size for monotonicity[3)]		5			mV
Linearity	Output Voltage Response		Linear			
Gain factor	Amplified Analog input Gain[2)]		7[1)]	8	9[1)]	
Vmax	Output Linearity Max Voltage	V_{INmax} = 250mV, V_{DD}=5V		2.2	2.4	V
Vmin	Output Linearity Min Voltage			200		mV

Notes:

1. Data based on characterization results over the whole temperature range, not tested in production.

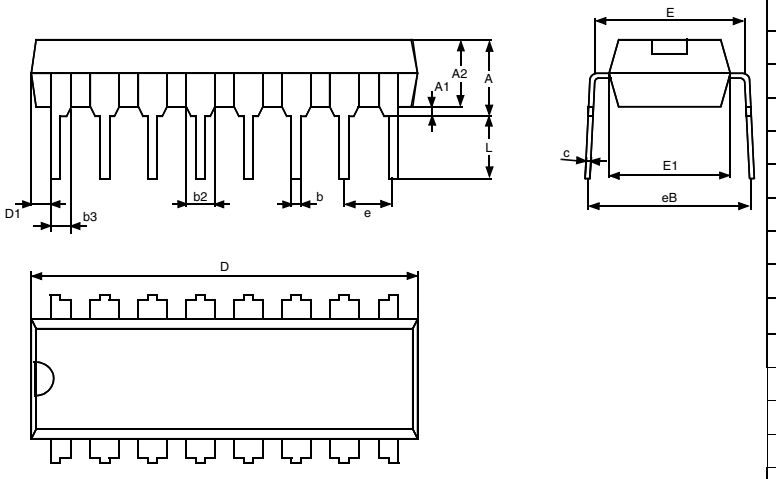
2. For precise conversion results it is recommended to calibrate the amplifier at the following two points:

– offset at V_{INmin} = 0V

– gain at full scale (for example V_{IN}=250mV)

3. Monotonicity guaranteed if V_{IN} increases or decreases in steps of min. 5mV.

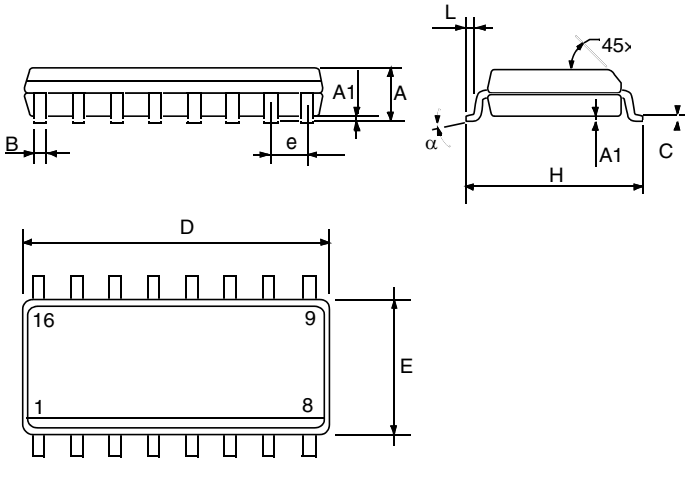
Figure 87. 16-Pin Plastic Dual In-Line Package, 300-mil Width



Dim	mm			inches[1]		
	Min	Typ	Max	Min	Typ	Max
A			5.33			0.2098
A1	0.38			0.0150		
A2	2.92	3.30	4.95	0.1150	0.1299	0.1949
b	0.36	0.46	0.56	0.0142	0.0181	0.0220
b2	1.14	1.52	1.78	0.0449	0.0598	0.0701
b3	0.76	0.99	1.14	0.0299	0.0390	0.0449
c	0.20	0.25	0.36	0.0079	0.0098	0.0142
D	18.67	19.18	19.69	0.7350	0.7551	0.7752
D1	0.13			0.0051		
e		2.54			0.1000	
E	7.62	7.87	8.26	0.3000	0.3098	0.3252
E1	6.10	6.35	7.11	0.2402	0.2500	0.2799
L	2.92	3.30	3.81	0.1150	0.1299	0.1500
eB			10.92			0.4299
	Number of Pins					
N	16					

Note 1. Values in inches are converted from mm and rounded to 4 decimal digits.

Figure 88. 16-Pin Plastic Small Outline Package, 150-mil Width



Dim.	mm			inches[1]		
	Min	Typ	Max	Min	Typ	Max
A	1.35		1.75	0.0531		0.0689
A1	0.10		0.25	0.0039		0.0098
B	0.33		0.51	0.0130		0.0201
C	0.19		0.25	0.0075		0.0098
D	9.80		10.00	0.3858		0.3937
E	3.80		4.00	0.1496		0.1575
e		1.27			0.0500	
H	5.80		6.20	0.2283		0.2441
α	0°		8°	0°		8°
L	0.40		1.27	0.0157		0.0500
	Number of Pins					
N	16					

Note 1. Values in inches are converted from mm and rounded to 4 decimal digits.

Table 24. ST7 Application Notes

IDENTIFICATION	DESCRIPTION
AN1071	HALF DUPLEX USB-TO-SERIAL BRIDGE USING THE ST72611 USB MICROCONTROLLER
AN1106	TRANSLATING ASSEMBLY CODE FROM HC05 TO ST7
AN1179	PROGRAMMING ST7 FLASH MICROCONTROLLERS IN REMOTE ISP MODE (IN-SITU PROGRAMMING)
AN1446	USING THE ST72521 EMULATOR TO DEBUG AN ST72324 TARGET APPLICATION
AN1477	EMULATED DATA EEPROM WITH XFLASH MEMORY
AN1527	DEVELOPING A USB SMARTCARD READER WITH ST7SCR
AN1575	ON-BOARD PROGRAMMING METHODS FOR XFLASH AND HDFLASH ST7 MCUS
AN1576	IN-APPLICATION PROGRAMMING (IAP) DRIVERS FOR ST7 HDFLASH OR XFLASH MCUS
AN1577	DEVICE FIRMWARE UPGRADE (DFU) IMPLEMENTATION FOR ST7 USB APPLICATIONS
AN1601	SOFTWARE IMPLEMENTATION FOR ST7DALI-EVAL
AN1603	USING THE ST7 USB DEVICE FIRMWARE UPGRADE DEVELOPMENT KIT (DFU-DK)
AN1635	ST7 CUSTOMER ROM CODE RELEASE INFORMATION
AN1754	DATA LOGGING PROGRAM FOR TESTING ST7 APPLICATIONS VIA ICC
AN1796	FIELD UPDATES FOR FLASH BASED ST7 APPLICATIONS USING A PC COMM PORT
AN1900	HARDWARE IMPLEMENTATION FOR ST7DALI-EVAL
AN1904	ST7MC THREE-PHASE AC INDUCTION MOTOR CONTROL SOFTWARE LIBRARY
AN1905	ST7MC THREE-PHASE BLDC MOTOR CONTROL SOFTWARE LIBRARY
SYSTEM OPTIMIZATION	
AN1711	SOFTWARE TECHNIQUES FOR COMPENSATING ST7 ADC ERRORS
AN1827	IMPLEMENTATION OF SIGMA-DELTA ADC WITH ST7FLITE05/09
AN2009	PWM MANAGEMENT FOR 3-PHASE BLDC MOTOR DRIVES USING THE ST7FMC
AN2030	BACK EMF DETECTION DURING PWM ON TIME BY ST7MC